Power MOSFET and Schottky Diode

30 V, 5.7 A, Single N-Channel with 30 V, 2.8 A, Schottky Barrier Diode

Features

- FETKY™ Surface Mount Package Saves Board Space
- Independent Pin-Out for MOSFET and Schottky Allowing for Design Flexibility
- Low R_{DS(on)} MOSFET and Low V_F Schottky to Minimize Conduction Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

Applications

- Disk Drives
- DC-DC Converters
- Printers

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Ratir	Symbol	Value	Unit		
Drain-to-Source Voltage)		V _{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	4.7	Α
Current R _{θJA} (Note 1)		T _A = 70°C		3.8	
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	1.6	W
Continuous Drain		T _A = 25°C	I _D	3.3	Α
Current R _{θJA} (Note 2)	Steady	T _A = 70°C		2.6	
Power Dissipation R ₀ JA (Note 2)	State	T _A = 25°C	P _D	0.77	W
Continuous Drain		T _A = 25°C	I _D	5.7	Α
Current $R_{\theta JA}$ t < 10 s (Note 1)		T _A = 70°C		4.5	
Power Dissipation $R_{\theta JA} t < 10 s \text{ (Note 1)}$		T _A = 25°C	P _D	2.3	W
Pulsed Drain Current		= 25°C, = 10 μs	I _{DM}	19	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	1.3	Α
Lead Temperature for So (1/8" from case for 10 s)		urposes	TL	260	°C

SCHOTTKY MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Peak Repetitive Reverse Voltage	V_{RRM}	30	V	
DC Blocking Voltage	V_R	30	V	
Average Rectified Forward Current, (Note 1)	Steady State	I _F	2.8	Α
	t < 10 s		4.1	



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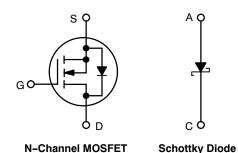
http://onsemi.com

N-CHANNEL MOSFET

V _{(BR)DSS}	R _{DS(on)} Max	I _D Max
30 V	48 mΩ @ 10 V	5.7 A
	70 m Ω @ 4.5 V	5 7.

SCHOTTKY DIODE

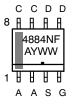
V _R Max	V _F Max	I _F Max
30 V	0.5 V	2.8 A



MARKING DIAGRAM & PIN ASSIGNMENT



SOIC-8 CASE 751 STYLE 18



4884NF = Device Code

A = Assembly Location
Y = Year
WW = Work Week
Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMD4884NFR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter MOSFET & Schottky	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	79	
Junction-to-Ambient – t ≤10 s Steady State (Note 1)	$R_{ heta JA}$	54	°C/W
Junction-to-FOOT (Drain) Equivalent to $R_{\theta JC}$	$R_{ heta JF}$	50	°C/VV
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	163	

- Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise noted)

Characteristic	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _I	ο = 250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				24		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μА
		$V_{DS} = 24 \text{ V}$	T _J = 125°C			20	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V$	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.0 A		34	48	m0
		V _{GS} = 4.5 V	I _D = 3.5 A		50	70	mΩ
Forward Transconductance	9FS	V _{DS} = 5.0 V, I _D = 4.0 A			10		S
Gate Resistance	R_{G}				2.4	3.6	Ω
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V			280	360	
Output Capacitance	C _{OSS}				60	80	pF
Reverse Transfer Capacitance	C _{RSS}	₽ DS =	10 1		32	42	1
Total Gate Charge	Q _{G(TOT)}				2.8	4.2	
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 4.0 \text{ A}$			0.4		nC
Gate-to-Source Charge	Q_{GS}				1.2		
Gate-to-Drain Charge	Q_{GD}				1.0		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 4.0 A			5.6	8.0	nC
SWITCHING CHARACTERISTICS (Note 4)					_		
Turn-On Delay Time	$t_{d(ON)}$				6.0	12	
Rise Time	t _r	V _{GS} = 10 V, \	/ _{DS} = 15 V,		6.5	13	1
Turn-Off Delay Time	t _{d(OFF)}	$I_{D} = 1.0 \text{ A, F}$			14	26	ns
Fall Time	t _f	1			1.4	7.0	7
DRAIN-TO-SOURCE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V	T _J = 25°C		0.8	1.0	V
		I _D = 1.3 A	T _J = 125°C		0.65	1	
Reverse Recovery Time	t _{RR}				9.2	20	1
Charge Time	t _a	$V_{GS} = 0 \text{ V}, d_{IS}/c$	d _t = 100 A/us,		6.0		ns
Discharge Time	t _b	I _S = 4	.0 A		3.2		
Reverse Recovery Time	Q _{RR}				3.3		nC

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol		Test Condition	Min	Тур	Max	Unit
CCHOTTKY DIODE ELECTRICAL CHA	DACTEDICTI	CC /T	OF OClane athemsise met	d\			

SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ($T_{.1} = 25$ °C ur	uniess otherwise noted)
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Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Maximum Instantaneous	V _F	I _F = 0.1 A	T _J = 25°C		0.26	0.28	V
Forward Voltage			T _J = 125°C		0.11	0.13	
		I _F = 2.0 A	T _J = 25°C		0.4	0.50	
			T _J = 125°C		0.35	0.46	
Maximum Instantaneous	I _R	V _R = 10 V	T _J = 25°C		0.020	0.25	mA
Reverse Current			T _J = 125°C		10	37	

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching characteristics are independent of operating junction temperatures.

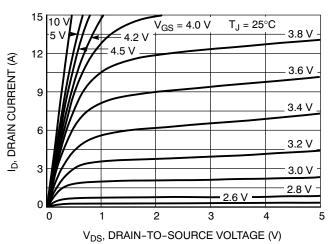


Figure 1. On-Region Characteristics

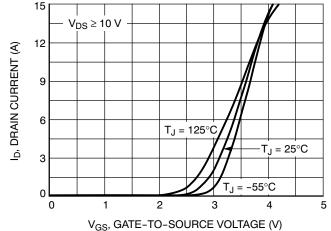


Figure 2. Transfer Characteristics

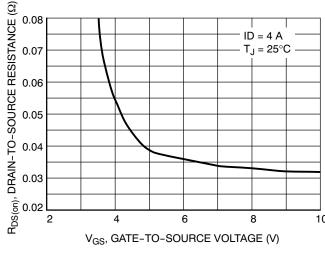


Figure 3. On-Resistance vs. Gate Voltage

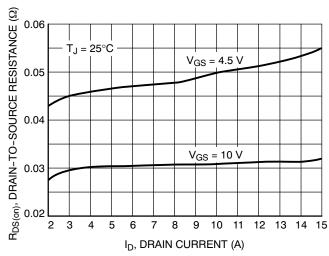


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

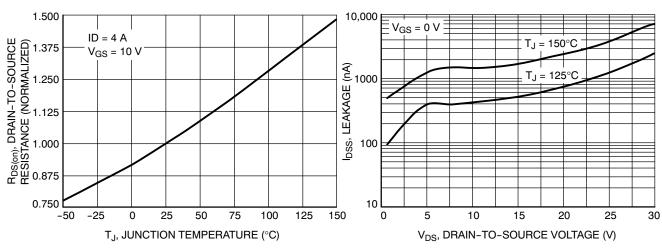


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

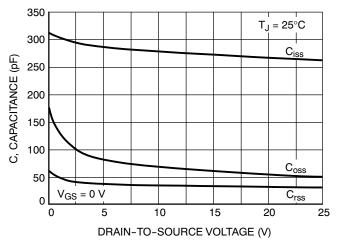


Figure 7. Capacitance Variation

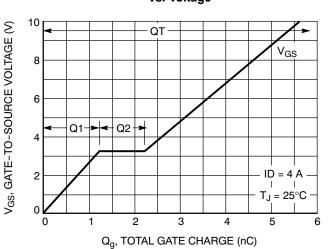


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

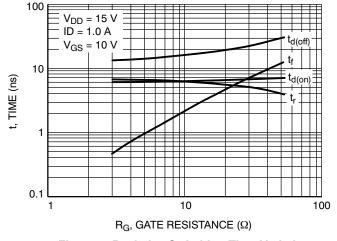


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

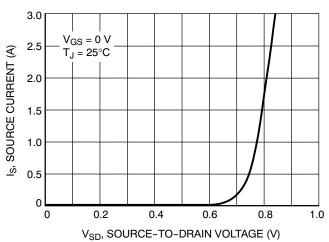


Figure 10. Diode Forward Voltage vs. Current

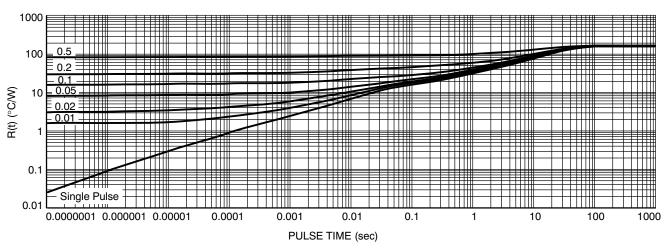


Figure 11. Thermal Response – $R_{\theta JA}$ at Steady State (min pad)

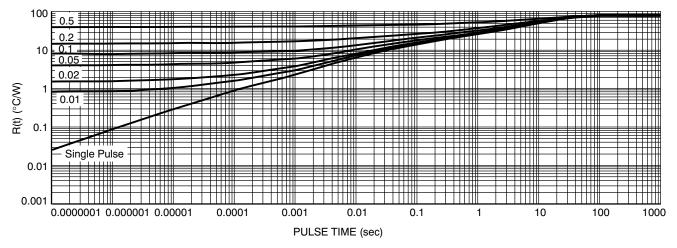


Figure 12. Thermal Response – $R_{\theta JA}$ at Steady State (1 inch sq pad)

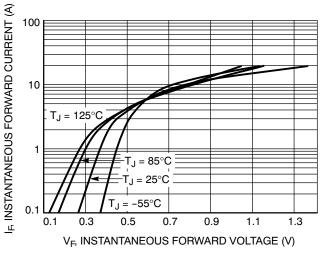


Figure 13. Typical Forward Voltage

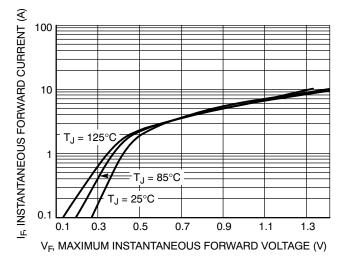


Figure 14. Maximum Forward Voltage

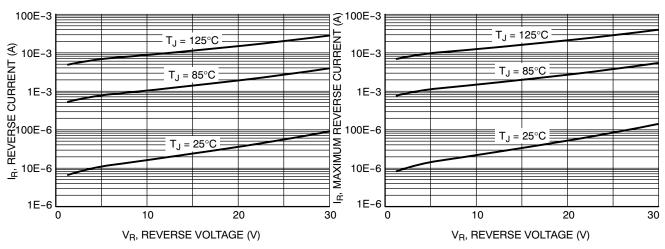


Figure 15. Typical Reverse Current

Figure 16. Maximum Reverse Current

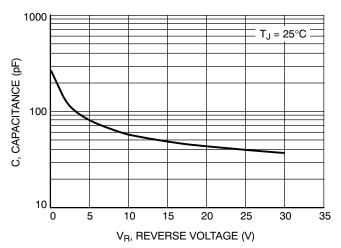
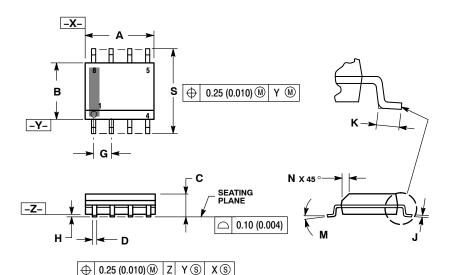


Figure 17. Capacitance



SOIC-8 NB CASE 751-07 **ISSUE AK**

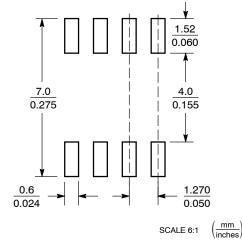
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

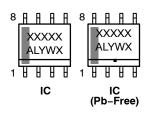
	MILLIN	IETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
C	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
M	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot

= Year = Work Week = Pb-Free Package

AYWW AYWW Ŧ \mathbb{H} Discrete **Discrete** (Pb-Free) XXXXXX = Specific Device Code

XXXXXX

= Assembly Location Α = Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

			27112 101 22 2
STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	8. DHAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	a COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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